

ABSTRACT

Particles in a glass substrate are measured by
executing following steps: sequentially conveying a
5 plurality of glass substrates; scanning with a camera a unit
area of a glass substrate in a direction of a travel path of
the glass substrate and storing particle information
thereof; shifting the camera to a position corresponding to
a next unit area for a succeeding glass substrate; storing
10 information on the particles in the unit area of the
succeeding glass substrate obtained by scanning the glass
substrate; estimating whether a sum of the respective
scanned unit areas is within an allowed limit of an area of
a glass substrate; and returning to the third step if an
15 answer from the fifth step is "No" or storing information on
the particles in the entire glass substrate if the answer is
"Yes".